Se	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/719,557	SWANSON ET AL.	
Examiner	Art Unit	
SANG KIM	3654	

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Class	Subclass	Date	Examiner
242	615.1	7-7-05	514
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEAR))
	DATE	EXMR
John Nguyen 242/6/5.2	7-7-05	sic